



MAIL STOP RCE  
PATENT  
4001-1154

IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Manfred SCHUSTER

Conf. 9804

Application No. 10/673,170

Group 2882

Filed September 30, 2003

Examiner Jurie Yun

PHASE CONTRAST X-RAY DEVICE FOR CREATING A PHASE CONTRAST  
IMAGE OF AN OBJECT AND METHOD FOR CREATING THE PHASE  
CONTRAST IMAGE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

August 1, 2006

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the cited documents are made of record on the enclosed PTO Form-1449.

As the USPTO has waived the requirement under 37 CFR 1.98(a)(2)(i) for submitting a copy of each cited U.S. patent and patent publication for applications filed after June 30, 2003, copies of the cited U.S. references are not enclosed, as the present application is filed after June 30, 2003. Copies of the cited foreign patent documents and/or non-patent literature are enclosed.


A concise explanation of the relevance of these items is that these references were discovered during any

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searches they or their client had made, or that they were considered in the preparation of the application.

Respectfully submitted,

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(Use several sheets if necessary)

Applicant:  
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Filing Date:  
**September 30, 2003**

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**10/673,170**

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Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	EP 0 818 131 B1	10/13/2004	Europe				
	EP 0 539 608 A1 (corresponding document to DE 69228285 T)	05/05/1993	Europe				
	EP 0 784 202 A2	07/16/1997	Europe				
	WO 96/31098 A1	10/03/1996	International				
	WO 95/05725 A1	02/23/1995	International				


DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

\* Abstract provided for the Examiner's convenience